

Form PTO-1449 (REV. 1/06)			US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 129526	APPLICATION NO. 10/594,061
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)			APPLICANT(S) Yuichi SHIBAZAKI			
			FILING DATE December 22, 2006		GROUP 2851	
U.S. PATENT DOCUMENTS						
Examiner Initials	Cite No.	Document Number	Date	Name		
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	19.	JP A 2004-61177	02/26/2004	JAPAN	X	X
	20.	JP A 11-87237	03/30/1999	JAPAN	X	X
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Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)				
EXAMINER					DATE CONSIDERED	
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